


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/707,687	CHEN ET AL.	
	Examiner	Art Unit	
	Monica Lewis	2822	

SEARCHED			
Class	Subclass	Date	Examiner
257	706,707, 787-796, 778,	3/7/2006	ML

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
East Search	3/8/2006	ML